



LFMND0P7



40V N-Channel MOSFETs

General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV_{DSS}	$R_{DS(ON)}$	I_D
40 V	0.7 m Ω	455 A

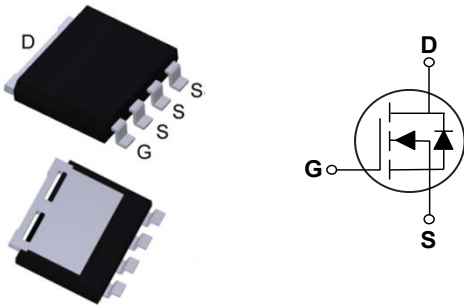
Features

- $R_{DS(ON)} \leq 0.7m\Omega @ V_{GS}=10V$
- Improved dv/dt Capability
- Fast Switching
- Green Device Available

Applications

- DC-DC Converters
- Body Control Electronics
- LED Lighting

LFPK8080 Pin Configuration



Ordering Information

Part No.	Remark	Package
LFMND0P7	Halogen Free	LFPK8080
LFMND0P7-A	AEC-Q101 qualified (NOTE 1)	

Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_C=25^\circ\text{C}$)	455	A
I_{DM}	Drain Current - Pulsed (NOTE 2)	1835	A
E_{AS}	Single Pulse Avalanche Energy ($L=0.1\text{mH}$)	500	mJ
I_{AS}	Single Pulse Avalanche Current ($L=0.1\text{mH}$)	100	A
P_D	Power Dissipation ($T_C=25^\circ\text{C}$)	417	W
T_J	Operating Junction Temperature Range	-55 to 175	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 175	$^\circ\text{C}$
Marking Code		ND0P7	

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	28	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction to Case	0.36	$^\circ\text{C/W}$

**Electrical Characteristics ($T_J=25^{\circ}\text{C}$, unless otherwise noted)****Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V$, $I_D=1mA$	40	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=32V$, $V_{GS}=0V$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$	---	---	± 100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V$, $I_D=25A$	---	0.54	0.7	$m\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250\mu A$	2.0	---	4.0	V

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Q_g	Total Gate Charge	$V_{DD}=20V$, $V_{GS}=10V$, $I_D=25A$	---	116	---	nC
Q_{gs}	Gate-Source Charge		---	36.5	---	
Q_{gd}	Gate-Drain Charge		---	10	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{DD}=20V$, $V_{GS}=10V$, $R_G=5\Omega$, $I_D=25A$	---	28.6	---	nS
T_r	Rise Time		---	39.1	---	
$T_{d(off)}$	Turn-Off Delay Time		---	98.2	---	
T_f	Fall Time		---	48	---	
C_{iss}	Input Capacitance	$V_{DS}=20V$, $V_{GS}=0V$, $f=1MHz$	---	9985	---	pF
C_{oss}	Output Capacitance		---	5746	---	
C_{rss}	Reverse Transfer Capacitance		---	109	---	
R_g	Gate Resistance	$V_{GS}=0V$, $V_{DS}=0V$, $f=1MHz$	---	1.9	---	Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{SD}	Diode Forward Voltage	$V_{GS}=0V$, $I_S=20A$	---	---	1.2	V
T_{rr}	Body Diode Reverse Recovery Time	$I_F=25A$, $di/dt=100A/\mu s$	---	116	---	nS
Q_{rr}	Body Diode Reverse Recovery Charge		---	338.1	---	nC

NOTES :

1. Qualified to AEC-Q101 standards for high reliability, but do not have all the necessary attributes of automotive grade products.
2. Repetitive Rating : Pulsed width limited by maximum junction temperature.
3. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.



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Characteristics Curves

FIG. 1-Continuous Drain Current vs. T_C

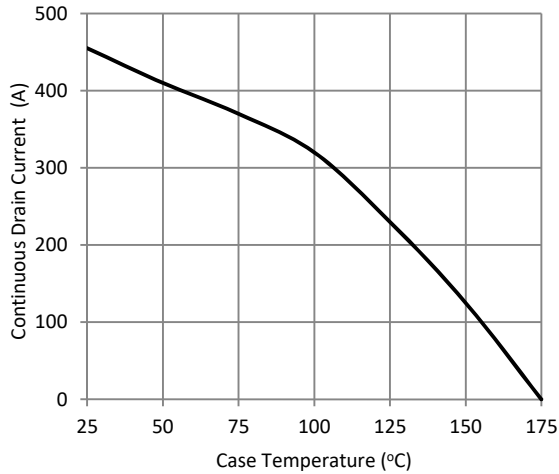


FIG. 2-Normalized $R_{DS(ON)}$ vs. T_J

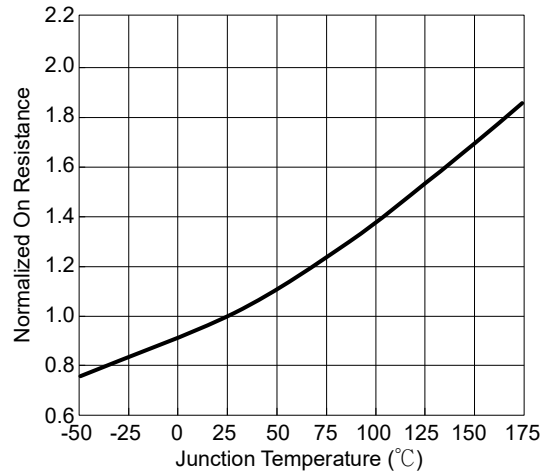


FIG. 3- V_{th} vs. T_J

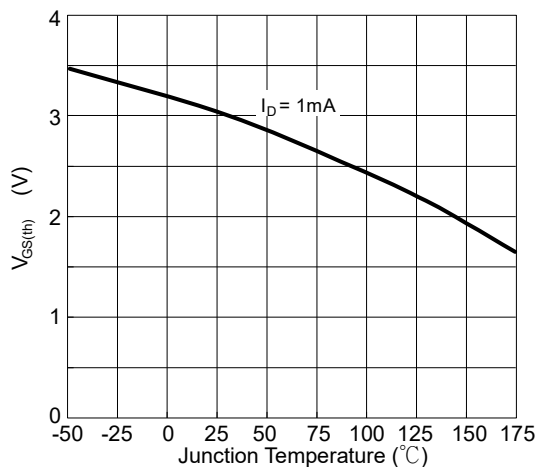


FIG. 4-Gate Charge Characteristics

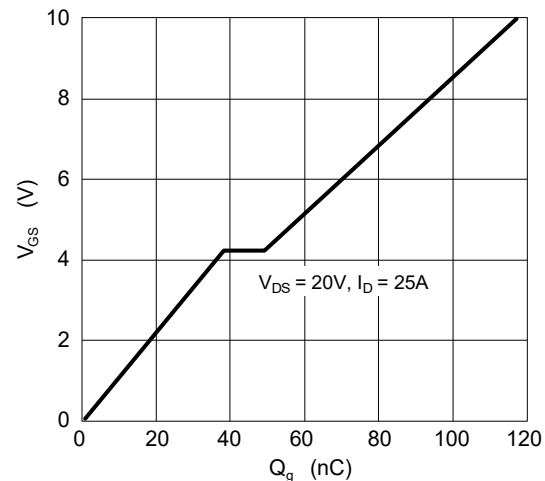


FIG. 5-Transient Thermal Resistance

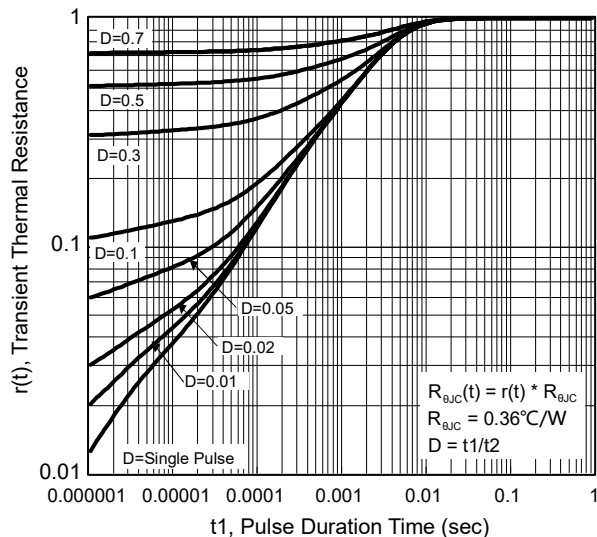
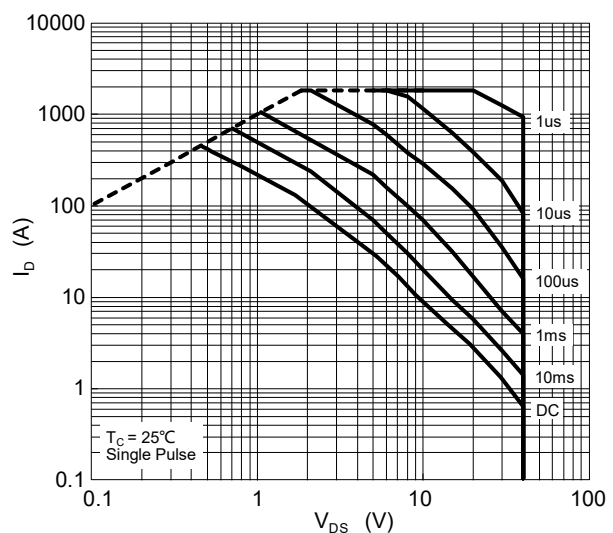


FIG. 6-Safe Operating Area





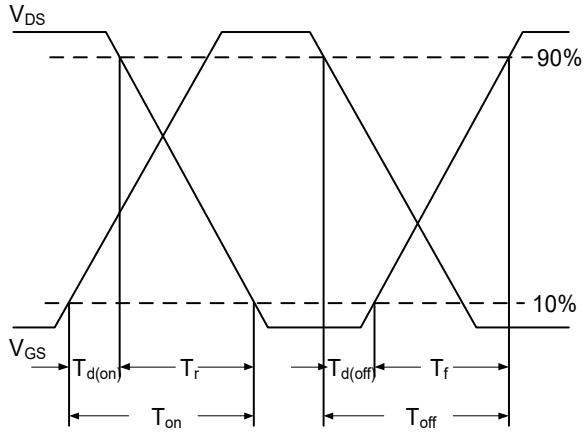
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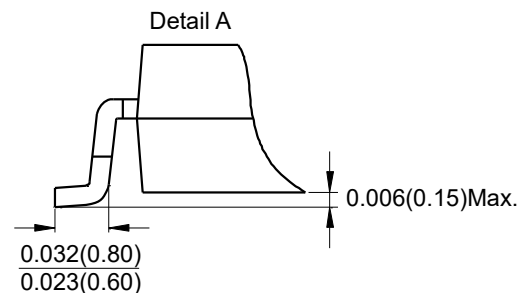
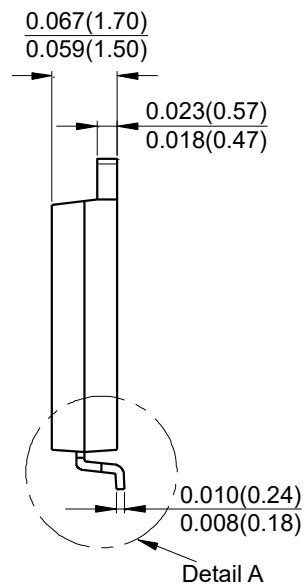
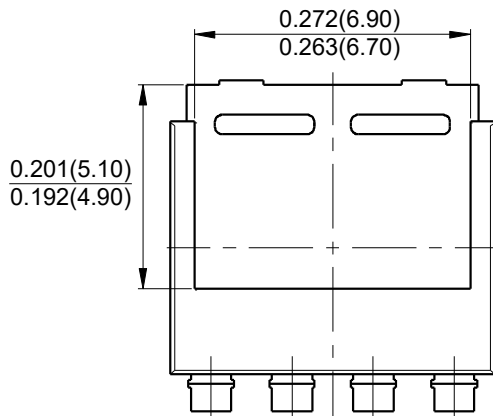
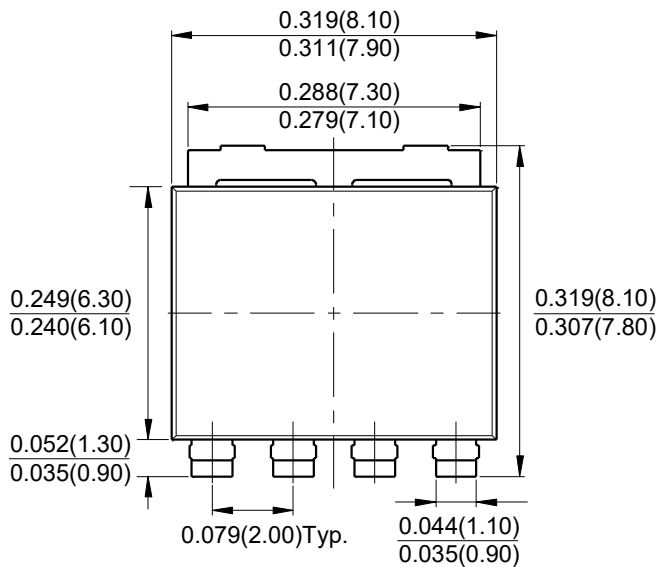
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Characteristics Curves

FIG. 7-Switching Time Waveform



Package Outline Dimensions



LFLPAK8080

Dimensions in inches and (millimeters)



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